

# APPLICATION NOTE

MITSUBISHI<IGBT MODULE>

Tentative

|      |           |     |   |                                     |
|------|-----------|-----|---|-------------------------------------|
| Pre. | S. Uchida | Rev | M | X. Kurachi<br>M. Tabata 26-Oct.-'01 |
| Apr. |           |     |   | 26-Jul.-03                          |

CM900DU-24NF

HIGH POWER SWITCHING USE

Notice : This is not a final specification. Some parametric limits are subject to change.

CM900DU-24NF

- $I_c$  ..... 900A
- $V_{CES}$  ..... 1200V
- Insulated Type
- 2-elements in a pack

## APPLICATION

UPS & General purpose inverters

F

## ABSOLUTE MAXIMUM RATINGS ( $T_j = 25^\circ\text{C}$ )

| Symbol    | Item                          | Conditions                             | Ratings         | Units            |
|-----------|-------------------------------|--|-----------------|------------------|
| $V_{CES}$ | Collector-emitter voltage     | G-E Short                              | 1200            | V                |
| $V_{GES}$ | Gate-emitter voltage          | C-E Short                              | $\pm 20$        | V                |
| $I_c$     | Collector current             | DC, $T_c = 96^\circ\text{C}$ *1        | 900             | A                |
|           |                               | Pulse ②                                | 1800            |                  |
| $I_E$ ①   | Emitter current               |  | 900             | A                |
|           |                               | Pulse ②                                | 1800            |                  |
| $P_c$ ③   | Maximum collector dissipation | $T_c = 25^\circ\text{C}$               | 2550            | W                |
| $T_j$     | Junction temperature          |  | $-40 \sim +150$ | $^\circ\text{C}$ |
| $T_{stg}$ | Storage temperature*4         |  | $-40 \sim +125$ | $^\circ\text{C}$ |
| $V_{iso}$ | Isolation voltage             | Main terminal to base plate, AC 1 min. | 2500            | V                |
| —         | Torque strength               | Main terminal M6                       | 3.5 ~ 4.5       | N·m              |
| —         | Torque strength               | Mounting holes M6                      | 3.5 ~ 4.5       | N·m              |
| —         | Weight                        | Typical value                          | 1400            | g                |

## APPLICATION NOTE

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CM900DU-24NF  
HIGH POWER SWITCHING USEELECTRICAL CHARACTERISTICS ( $T_j = 25^\circ\text{C}$ )

| Symbol                         | Item  | Conditions   | Min. | Typ.  | Max.  | Units            |      |
|--------------------------------|---|--|------|-------|-------|------------------|------|
| $I_{CES}$                      | Collector cutoff current  | $V_{CE}=V_{CES}, V_{GE}=0\text{V}$   | —    | —     | 1     | mA               | F    |
| $V_{GE(\text{th})}$            | Gate-emitter threshold voltage                                    | $I_c=90\text{mA}, V_{CE}=10\text{V}$   | 6    | 7     | 8     | V                | F    |
| $I_{GES}$                      | Gate leakage current  | $V_{GE}=V_{GES}, V_{CE}=0\text{V}$   | —    | —     | 1.0   | $\mu\text{A}$    | L    |
| $V_{CE(\text{sat})}$<br>(chip) | Collector to emitter saturation voltage (without lead resistance) | $T_j = 25^\circ\text{C}$ $I_c = 900\text{A}$   | —    | 1.8   | 2.5   | V                | H    |
|                                |   | $T_j = 125^\circ\text{C}$ $V_{GE}=15\text{V}$ ④  | —    | 2.0   | —     |                  |      |
| $R(\text{lead})$               | Module lead resistance  | $I_c = 900\text{A}$ , terminal-chip  | —    | 0.286 | —     | $\text{m}\Omega$ | C M  |
| $C_{ies}$                      | Input capacitance   | $V_{CE}=10\text{V}$<br>$V_{GE}=0\text{V}$  | —    | —     | 140   |                  | F    |
| $C_{oes}$                      | Output capacitance  |  | —    | —     | 16    | nF               | F    |
| $C_{res}$                      | Reverse transfer capacitance                                      |  | —    | —     | 3     |                  | F    |
| $Q_g$                          | Total gate charge   | $V_{CC}=600\text{V}, I_c=900\text{A}, V_{GE}=15\text{V}$   | —    | 4800  | —     | nC               |      |
| $t_{d(on)}$                    | Turn-on delay time  | $V_{CC}=600\text{V}, I_c=900\text{A}$<br>$V_{GE1}=V_{GE2}=15\text{V}$<br>$R_g=0.35\Omega$ , inductive load<br>switching operation<br>$I_E=900\text{A}$ | —    | —     | 600   |                  | F J  |
| $t_r$                          | Turn-on rise time   |  | —    | —     | 200   | ns               | F    |
| $t_{d(off)}$                   | Turn-off delay time   |  | —    | —     | 800   |                  | F    |
| $t_f$                          | Turn-off fall time  |  | —    | —     | 300   |                  | F    |
| $t_{rr}$ ①                     | Reverse recovery time   |  | —    | —     | 500   | ns               | F    |
| $Q_{rr}$ ①                     | Reverse recovery charge   |  | —    | 50    | —     | $\mu\text{C}$    | F    |
| $V_{EC}$ ①                     | Emitter-collector voltage (without lead resistance)               | $I_E=900\text{A}, V_{GE}=0\text{V}$  | —    | —     | 3.2   | V                | F L  |
| $R_{th(j-c)Q}$                 | Thermal resistance <sup>3</sup>                                   | IGBT part (1/2module)  | —    | —     | 0.049 |                  | H    |
| $R_{th(j-c)R}$                 |   | FWDi part (1/2module)  | —    | —     | 0.078 |                  |      |
| $R_{th(j-c')Q}$                | Thermal resistance <sup>3</sup>                                   | Tc measured point is just under the chips(IGBT part)   | —    | —     | 0.021 |                  | °C/W |
| $R_{th(j-c')R}$                |   | Tc measured point is just under the chips(FWDi part)   | —    | —     | 0.034 |                  |      |
| $R_{th(c-f)}$                  | Contact thermal resistance <sup>2</sup>                           | Case to fin, Thermal compound Applied (1/2module)  | —    | 0.016 | —     |                  |      |
| $R_g$                          | External gate resistance  |  | 0.35 | —     | 2.2   | $\Omega$         | G J  |

\*1: Tc' measured point is just under the chips.

If you use this value,  $R_{th(f-a)}$  should be measured just under the chips.

\*2: Typical value is measured by using Shin-etsu Silicone "G-746".

\*3: Tc measured point is shown in page "3-3".

\*4: The operation temperature is restrained by the permission temperature of female connector.

①  $I_E, V_{EC}, t_{rr}$  &  $Q_{rr}$  represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWDi).② Pulse width and repetition rate should be such that the device junction temp. ( $T_j$ ) dose not exceed  $T_{jmax}$  rating.③ Junction temperature ( $T_j$ ) should not increase beyond  $150^\circ\text{C}$ .

④ Pulse width and repetition rate should be such as to cause negligible temperature rise.

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HIGH POWER SWITCHING USE

## OUTLINE DRAWING

A,B HOUSING Type

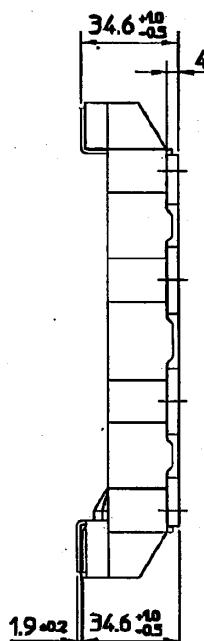
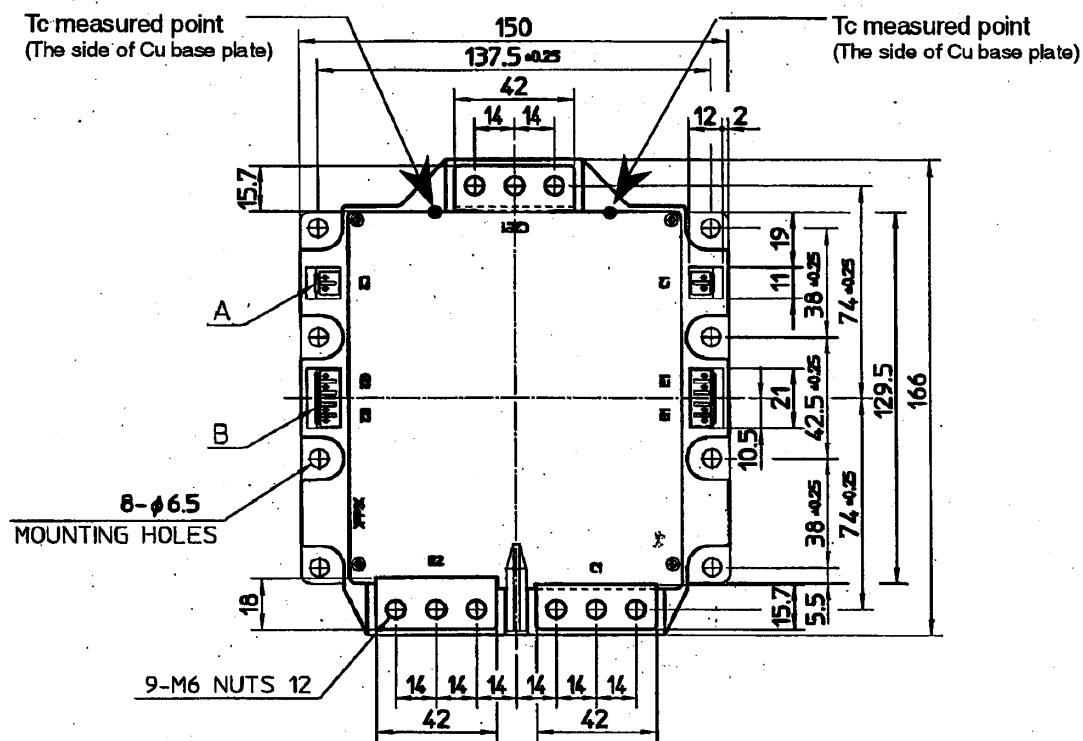
(U.S.T.Mfg.Co.Ltd)

A : VHR-2N

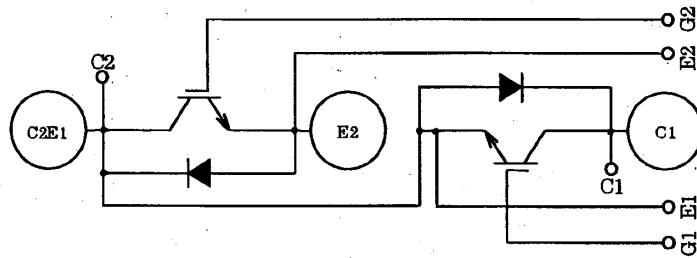
B : VHR-5N

Dimensions in mm

|   |   |
|---|---|
|   | B |
| G | D |
| H | E |



## CIRCUIT DIAGRAM



Terminal name

